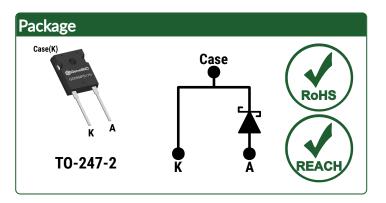
GeneSic SEMICONDUCTOR

Silicon Carbide Schottky Diode

 $V_{RRM} = 1700 V$ $I_{F(T_{C} = 165^{\circ}C)} = 5 A$ $Q_{C} = 41 nC$

Features

- Gen4 Thin Chip Technology for Low V_F
- Enhanced Surge and Avalanche Robustness
- Superior Figure of Merit Qc/IF
- Low Thermal Resistance
- Low Reverse Leakage Current
- Temperature Independent Fast Switching
- Positive Temperature Coefficient of V_F
- Low V_F for High Temperature Operation



Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Improved System Efficiency

Applications

- EV Fast Chargers
- Solar Inverters
- Anti-Parallel / Free-Wheeling Diode
- Motor Drives
- High Frequency Rectifiers
- Switched Mode Power Supply (SMPS)
- Induction Heating and Welding
- Medical Imaging

Absolute Maximum Ratings (At T_C = 25°C Unless Otherwise Stated) Parameter Symbol

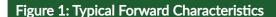
Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage	V_{RRM}		1700	٧	
		$T_C = 100^{\circ}C, D = 1$	16		
Continuous Forward Current	l _F	$T_C = 135^{\circ}C$, D = 1	11	Α	Fig. 4
		$T_C = 165^{\circ}C, D = 1$	5		
Non-Repetitive Peak Forward Surge Current, Half Sine	leau.	T_C = 25°C, t_P = 10 ms	50	٨	
Wave	IF,SM	$T_C = 150^{\circ}C$, $t_P = 10 \text{ ms}$	40	Α	
Repetitive Peak Forward Surge Current, Half Sine Wave	len	$T_C = 25^{\circ}C$, $t_P = 10 \text{ ms}$	30	۸	
Kepetitive Feak Forward Surge Current, Half Sine wave	I _{F,RM}	$T_C = 150^{\circ}C$, $t_P = 10 \text{ ms}$	21	Α	
Non-Repetitive Peak Forward Surge Current	I _{F,MAX}	T_C = 25°C, t_P = 10 μ s	250	Α	
i ² t Value	∫i²dt	$T_C = 25^{\circ}C$, $t_P = 10 \text{ ms}$	12	A ² s	
Non-Repetitive Avalanche Energy	E _{AS}	L = 8.0 mH, I _{AS} = 5 A	100	mJ	
Diode Ruggedness	dV/dt	V _R = 0 ~ 1360 V	200	V/ns	
Power Dissipation	Ртот	T _C = 25°C	164	W	Fig. 3
Operating and Storage Temperature	T _j , T _{stg}		-55 to 175	°C	

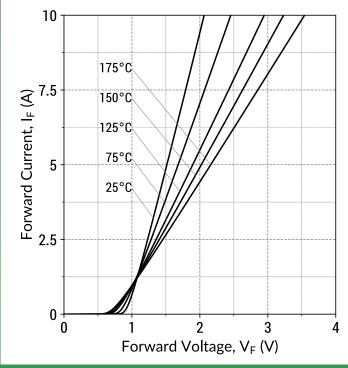


Electrical Characteristics								
Parameter	Symbol	Conditions		Values			Unit	Note
r al allietei	Syllibol			Min.	Тур.	Max.	Oilit	Note
Diodo Forward Voltago	V_{F}	I _F = 5 A, T _j = 25°C			1.5	1.8	V	Fig. 1
Diode Forward Voltage	٧F	I _F = 5 A, T _j = 175°C			2.1			
Reverse Current	l _n	V _R = 1700 V, T _j = 25°C			1	5	μΑ	Fig. 2
	I _R	$V_R = 1700 \text{ V, } T_j = 175^{\circ}\text{C}$			4			
Total Capacitive Charge	Qc		$V_{R} = 600 \text{ V}$		28		nC	Fig. 7
	Q C	$I_{F} \leq I_{F,MAX}$	$V_R = 1200 V$		41			
Switching Time	+-	dl _F /dt = 200 A/μs	V _R = 600 V		< 10		no	
	ts	V _R = 1200 V			\ 10		ns	
Total Capacitance	С	V_R = 1 V, f = 1MHz V_R = 1200 V, f = 1MHz			361		nE	Fig. 6
					20		pF	

Thermal/Package Characteristics							
Parameter	Symbol	Conditions		Values			Note
Faranieter		Colluitions	Min.	Тур.	Max.	- Unit	Note
Thermal Resistance, Junction - Case	R_{thJC}			0.91		°C/W	Fig. 9
Weight	W _T			6.0		g	
Mounting Torque	T _M	Screws to Heatsink			1.1	Nm	

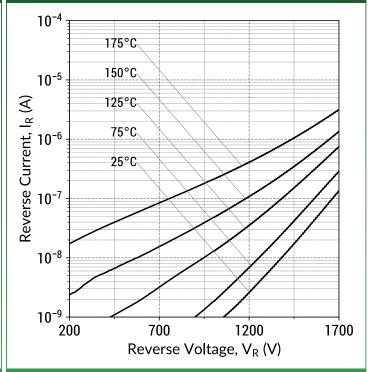






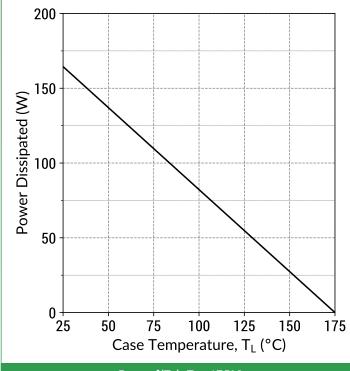
 $I_F = f(V_F, T_j); t_P = 250 \mu s$

Figure 2: Typical Reverse Characteristics



 $I_R = f(V_R, T_j)$

Figure 3: Power Derating Curves



 $P_{TOT} = f(T_C); T_j = 175^{\circ}C$

Figure 4: Current Derating Curves (Typical V_F)

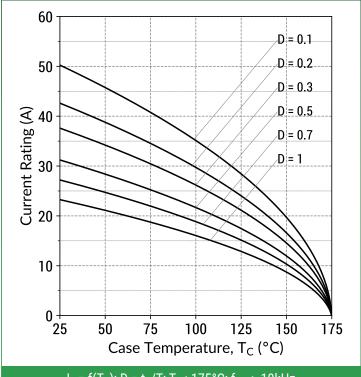
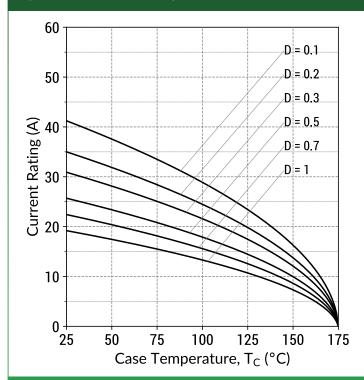


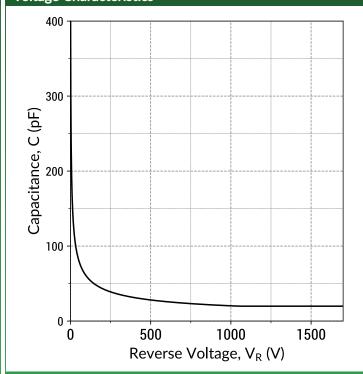


Figure 5: Current Derating Curves (Maximum V_F)



 $I_F = f(T_C); D = t_P/T; T_j \le 175^{\circ}C; f_{SW} > 10kHz$

Figure 6: Typical Junction Capacitance vs Reverse Voltage Characteristics



 $C = f(V_R)$; f = 1MHz

Figure 7: Typical Capacitive Charge vs Reverse Voltage Characteristics

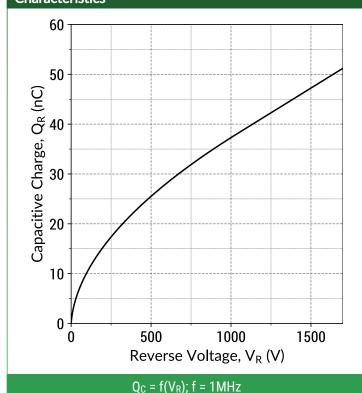


Figure 8: Typical Capacitive Energy vs Reverse Voltage Characteristics

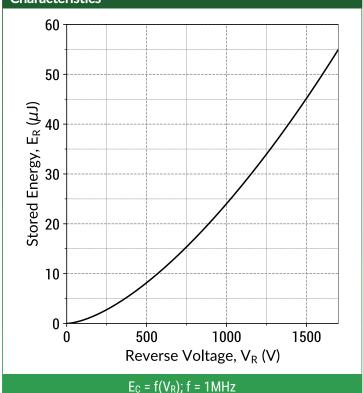
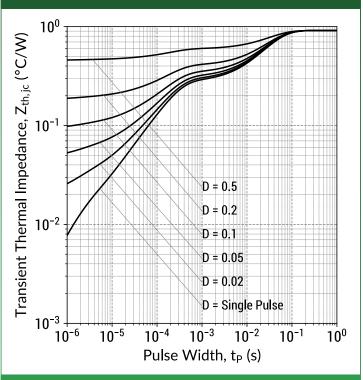


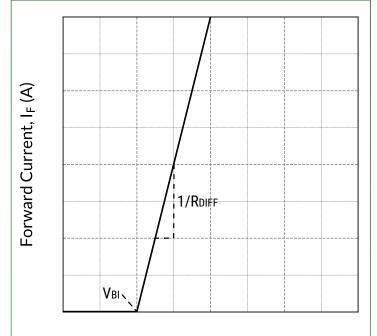


Figure 9: Transient Thermal Impedance



 $Z_{th,jc} = f(t_P,D); D = t_P/T$

Figure 10: Forward Curve Model



Forward Voltage, $V_F(V)$

 $I_F = f(V_F, T_j)$

Forward Curve Model Equation:

 $I_F = (V_F - V_{BI})/R_{DIFF}(A)$

Built-In Voltage (V_{BI}):

$$V_{BI}(T_j) = m \times T_j + n (V)$$

 $m = -0.00126 (V/^{\circ}C)$
 $n = 0.997 (V)$

Differential Resistance (RDIFF):

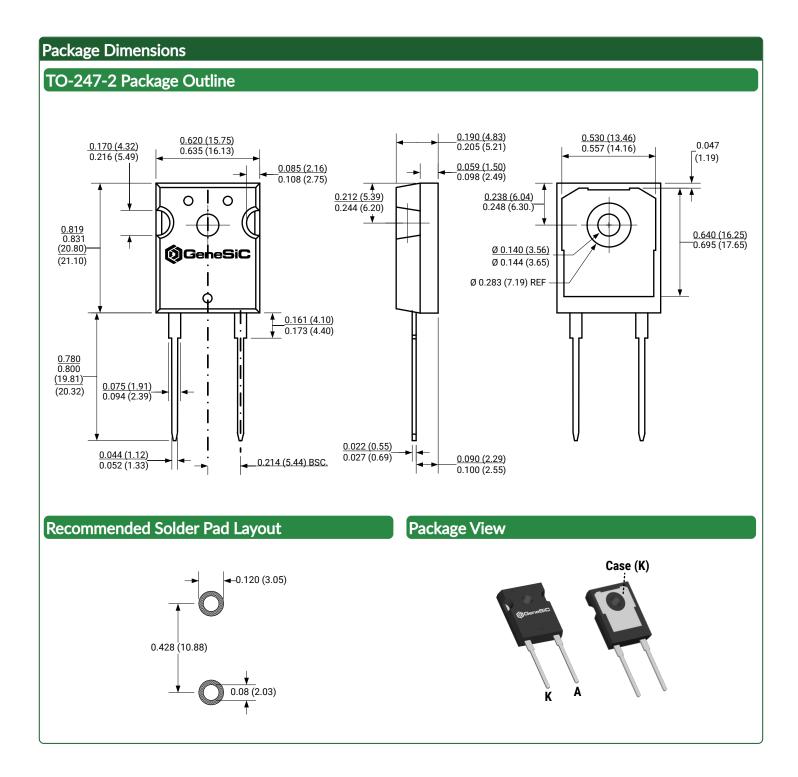
$$R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c (\Omega)$$

 $a = 2.04e-06 (\Omega/^{\circ}C^2)$
 $b = 0.000704 (\Omega/^{\circ}C)$
 $c = 0.0912 (\Omega)$

Forward Power Loss Equation:

$$P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$$





NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.





Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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 PLECS Models: https://www.genesicsemi.com/sic-schottky-mps/GD05MPS17H/GD05MPS17H_PLECS.zip
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Reliability: https://www.genesicsemi.com/reliability
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 Quality Manual: https://www.genesicsemi.com/quality

Revision History

Date	Revision	Comments	Supersedes
Jul. 27, 2020	Rev 1	Initial Release	



www.genesicsemi.com/sic-schottky-mps/

